

3. A silicon p -channel (n -substrate) MOS capacitor with a polysilicon gate heavily doped with boron ($E_f = E_v$) has a substrate doping of $N_d = 2 \times 10^{18} \text{ cm}^{-3}$ and an oxide thickness of $x_{ox} = 2 \text{ nm}$. There are no significant interface charges. The device is biased such that the voltage dropped across the oxide is 0.5 V (more positive toward gate).

- (a) Calculate the charge in the semiconductor and on the gate. What mode is the device operating in? (10)

$$V_{ox} = \frac{Q_g}{C_{ox}'} = -\frac{Q_s}{C_{ox}'} \quad (\text{no oxide charges})$$

$$C_{ox}' = \frac{\kappa_{ox} \epsilon_0}{x_{ox}} = \frac{3.9 \times 8.854 \times 10^{-14} \text{ F/cm}}{2 \times 10^{-7} \text{ cm}} = 1.73 \times 10^{-6} \text{ F/cm}^2$$

$$Q_g = 0.5 \text{ V} \times 1.73 \times 10^{-6} \text{ F/cm}^2 = 8.6 \times 10^{-7} \text{ C/cm}^2$$

$$Q_s = -Q_g = -8.6 \times 10^{-7} \text{ C/cm}^2 < 0 \Rightarrow \text{accumulation of electrons in } n\text{-substrate}$$

- (b) What is the applied voltage between the gate and substrate? (12)

$$V_{GB} = V_{FB} + V_s + \Delta V_{ox} = \phi_{ms} + V_s + V_{ox}$$

$$\phi_m = \chi_s + E_g, \quad \phi_s = \chi_s + \frac{kT}{q} \ln \frac{N_c}{N_d} = \chi_s + 0.07 \text{ V}$$

$$\phi_{ms} = 1.12 - 0.07 = 1.05 \text{ V}$$

$$V_s \approx 0 \text{ in accumulation}$$

$$V_{GB} = 1.05 + 0.5 = 1.55 \text{ V}$$

4. A silicon n-channel MOS transistor has an oxide thickness of 2 nm, uniform substrate doping of $N_a = 2 \times 10^{18} \text{ cm}^{-3}$ and $W = 300 \text{ nm}$ and $L = 100 \text{ nm}$. $V_T = 0.4 \text{ V}$ with $V_S = V_B = 0 \text{ V}$. Assume $\mu'_n = 150 \text{ cm}^2/\text{Vs}$ in the inversion layer.

- (a) If the gate metal work function is 4.0V, what must the oxide interface charges be (assume no charges in bulk of oxide)? (12)

$$V_T = V_{FB} - 2\phi_F - \frac{Q'_{d, \max}}{C_{ox}}$$

$$V_{FB} = \phi_{ms} - \frac{Q'_{ss}}{C_{ox}}$$

$$6.4 \text{ V} = \phi_{ms} - \frac{Q'_{ss}}{C_{ox}} + 0.99 + \frac{8.14 \times 10^{-7} \text{ C/cm}^2}{1.73 \times 10^{-6} \text{ F/cm}^2}$$

$$\phi_F = \phi_p = -\frac{kT}{q} \ln\left(\frac{N_a}{n_i}\right) = -0.495$$

$$\phi_s = \chi_s + E_g - \frac{kT}{q} \ln\left(\frac{N_a}{N_d}\right) = 4.05 + 1.12 - 0.07$$

$$Q'_{d, \max} = -\sqrt{2qK_s\epsilon_0 N_d | -2\phi_F |}$$

$$= \sqrt{2(1.6 \times 10^{-19} \text{ C})(11.8 \times 8.854 \times 10^{-14} \text{ F/cm})(2 \times 10^{18} \text{ cm}^{-3})}$$

$$= 8.14 \times 10^{-7} \text{ C/cm}^2$$

$$Q'_{ss} = C_{ox} [0.99 - 1.1 + 0.47 - 0.4]$$

$$= -6.9 \times 10^{-8} \text{ C/cm}^2$$

- (b) Calculate the change in threshold voltage with the change in channel to substrate bias (δ) for $V_{SB} = 0$. (12)

$$\delta = \frac{C_d'}{C_{ox}}$$

$$C_d' = \frac{K_s \epsilon_0}{x_d}$$

$$x_d = \frac{Q'_{d, \max}}{q N_a} = \frac{8.14 \times 10^{-7} \text{ C/cm}^2}{(1.6 \times 10^{-19} \text{ C})(2 \times 10^{18} \text{ cm}^{-3})}$$

$$= 2.54 \times 10^{-6} \text{ cm}$$

$$C_d' = \frac{(11.8)(8.854 \times 10^{-14} \text{ F/cm})}{2.54 \times 10^{-6} \text{ cm}}$$

$$= 4.1 \times 10^{-7} \text{ F/cm}^2$$

$$\delta = \frac{4.1 \times 10^{-7} \text{ F/cm}^2}{1.73 \times 10^{-6} \text{ F/cm}^2} = 0.24$$

- (c) If $V_S = V_B = 0 \text{ V}$ and $V_G = 2 \text{ V}$, what drain voltage would bring the transistor to the edge of saturation. (Use full or linearized model). (8)

$$V_{DS}^{\text{sat}} = \frac{V_{GS} - V_T}{1 + \delta} = \frac{2 - 0.4}{1.24} = 1.29 \text{ V}$$

- (d) For $V_D = 2V$ (and $V_S = V_B = 0V$, $V_G = 2.0V$), determine the operating mode and calculate the drain current. Include channel length modulation if appropriate. (14)

$$V_{DS} = 2V > V_{DS}^{sat} = 1.29V \quad L = L - \Delta L = 8 \times 10^{-6} \text{ cm}$$

$$I_{DS}^{sat} = \mu_n \frac{W}{L} C_{ox} \frac{(V_{DS}^{sat} - V_T)^2}{2(1+\delta)}$$

$$= (1.6 \times 10^{-19} \text{ C}) \left(\frac{150 \text{ cm}^2}{V \cdot s} \right) \left(\frac{300}{80} \right) \left(1.73 \times 10^{-6} \frac{F}{\text{cm}^2} \right)$$

$$\frac{(2 - 0.4)^2}{2 \times 1.24} = 1.0 \times 10^{-3} \text{ A} = 1 \text{ mA}$$

$$\Sigma_{eff} = \frac{V_{GS} + V_T + 0.2}{6 \text{ tox}} = 2.2 \times 10^6 \frac{V}{\text{cm}}$$

$$\mu_n' \approx 90 \text{ cm}^2/V \cdot s \text{ from plot, but use } 150$$

- (e) Sketch the band diagram in channel near drain if $V_G = 2.0V$, $V_D = 2V$, and $V_S = V_B = 0V$. What is the voltage dropped across the semiconductor? (12)

$V_{DS} > V_{DS}^{sat}$, so drain end of channel not inverted

$$V_{GB} = V_{FB} + V_S + \frac{\sqrt{2K_s \epsilon_0 q N_A V_S}}{C_{ox}}$$

$$= \phi_{MS} - \frac{Q_{ss}'}{C_{ox}} + V_S + 0.47 \sqrt{V_S}$$

$$2 = -1.1 + 0.4 + V_S + 0.47 \sqrt{V_S}$$

$$x = \sqrt{V_S}$$

$$x^2 + 0.47x - 3.06 = 0$$

$$x = \frac{-0.47 \pm \sqrt{(0.47)^2 + 4(3.06)}}{2}$$

$$= 1.53$$

$$V_S = 2.34 \text{ V}$$

